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# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re Application of:

Choi, et al.

Serial No. 09/920,341

Filed: August 1, 2001

For: METHODS FOR HIGH-PRECISION

GAP ORIENTATION SENSING BETWEEN A TRANSPARENT

TEMPLATE AND SUBSTRATE FOR

IMPRINT LITHOGRAPHY

Examiner: Unknown

Group Art Unit: 1724

Atty. Dkt. 5119-08301

Certificate of Mailing 37 C.F.R. § 1.8(a)

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as First Class Mail, postage prepaid, in an envelope addressed to: Commissioner for Patents, Washington, D.C. 20231, on the date below:

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Date

Kathy Norman

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Washington, D.C. 20231

Sir:

JUN 26 2002

It is respectfully requested that this Information Disclosure Statement be entered and the documents listed on attached Form PTO-1449 (references A1-A118) be considered by the Examiner and made of record. A copy of each listed document is enclosed for the convenience of the Examiner.

Applicant also requests that the Examiner consider the following U.S. Patent applications with amendments, as noted: 09/908,455 (with amendment); 09/907,512 (with amendment); 09/934,248 (with amendment); 09/698,317 (with amendment); 09/976,681; and 09/908,765. Copies of these applications and amendments are enclosed for the convenience of the Examiner.

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Should any fees be required, the Commissioner is authorized to charge said fees to Conley, Rose & Tayon, P.C. Deposit Account No. 50-1505/5119-08301.

Respectfully submitted,

Eric B. Meyertons Reg. No. 34,876

Attorney for Applicant(s)

CONLEY, ROSE & TAYON, P.C. P.O. BOX 398 AUSTIN, TEXAS 78767-0398

(512) 476-1400

Date: 6/11/02

\* Form PTO-1449 (modified)

List of Patents and Publications

O PFe Applicant's Information

Disclosure Statement

(Use Coveral sheets if necessary)

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SERIAL NO. 09/920,341

GROUP: 1724

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FILING DATE: August 1, 2001

ATTY. DKT. NO. 5119-08301

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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.

Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement

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